

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/606,266	HANYU ET AL.	
Examiner		Art Unit		Page 1 of 1
Kimberly D. Nguyen		2876		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,618,063	04-1997	Chang et al.	283/67
*	B	US-4,109,047	08-1978	Fredrickson, Donald M.	503/205
*	C	US-5,344,191	09-1994	Chang et al.	283/72
*	D	US-5,458,307	10-1995	Gebka, John	248/205.3
*	E	US-6,126,125	10-2000	Dalton, Gary C.	248/205.2
*	F	US-5,218,192	06-1993	Fujii et al.	235/487
*	G	US-5,930,206	07-1999	Haas et al.	368/327
*	H	US-6,217,966	04-2001	Finster et al.	428/42.1
*	I	US-6,568,111	05-2003	Forsythe et al.	40/657
*	J	US-6,581,828	06-2003	Forsythe et al.	235/383
*	K	US-6,621,407	09-2003	Goodwin, III, John C.	340/5.91
*	L	US-6,742,294	06-2004	Fossum, Stein Arne	40/611.1
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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